

FDPF3860T

N-Channel PowerTrench[®] MOSFET 100V, 20A, 38.2m Ω

Description

- $R_{DS(on)} = 38.2 m\Omega$ (MAX) @ $V_{GS} = 10 V$, $I_D = 5.9 A$
- · Fast switching speed
- · Low gate charge
- High performance trench technology for extremely low R_{DS(on)}
- High power and current handling capability
- · RoHS compliant



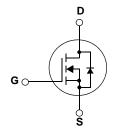
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

• DC to AC converters / Synchronous Rectification





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter		Ratings	Units
V_{DSS}	Drain to Source Voltage			100	V
V_{GSS}	Gate to Source Voltage			±20	V
	Drain Current	- Continuous (T _C = 25°C)		20	A
ID	Drain Current	- Continuous (T _C = 100°C)		12.7	A
I _{DM}	Drain Current	- Pulsed	(Note 1)	80	А
E _{AS}	Single Pulsed Avalanche I	Energy	(Note 2)	278	mJ
I _{AR}	Avalanche Current		(Note 1)	20	А
E _{AR}	Repetitive Avalanche Energy		(Note 1)	3.4	mJ
dv/dt	Peak Diode Recovery dv/d	dt	(Note 3)	15	V/ns
Б	Davier Dissipation	$(T_C = 25^{\circ}C)$		33.8	W
P_{D}	Power Dissipation	- Derate above 25°C		0.27	W/°C
T _J , T _{STG}	Operating and Storage Te	mperature Range		-55 to +150	°C
T _L	Maximum Lead Temperate 1/8" from Case for 5 Seco	• •		300	°C

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 62.5		-0/00

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF3860T	FDPF3860T	TO-220F	-	=	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V, T_J = 25^{\circ} C$	100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.1	-	V/°C
I	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$	-	-	1	μА
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 48V, T_{C} = 150^{\circ}C$	-	-	500	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	-	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 5.9A$	-	29.1	38.2	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 5.9A$ (Note 4)	-	21	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V	-	1350	1800	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	•	145	190	pF
C _{rss}	Reverse Transfer Capacitance	1 = 11011 12	1	60	90	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	15	40	ns
t _r	Turn-On Rise Time	$V_{DD} = 50V, I_D = 5.9A$		-	17	45	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$		-	24	60	ns
t _f	Turn-Off Fall Time		(Note 4, 5)	-	7	25	ns
Q _{g(tot)}	Total Gate Charge at 10V			-	23	35	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 80V, I_{D} = 5.9A$		-	7	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V	(Note 4, 5)	-	8	-	nC

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	20	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	80	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 5.9A$	-	-	1.3	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 5.9A$	-	40	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note	4) -	56	-	nC

Notes

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L =16mH, I $_{AS}$ = 5.9A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C
- 3. I $_{SD}$ \leq 5.9A, di/dt \leq 200A/ μ s, V $_{DD}$ \leq BV $_{DSS}$, Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

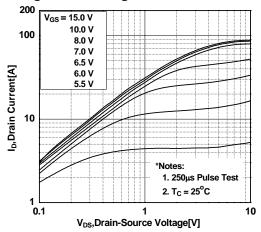


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

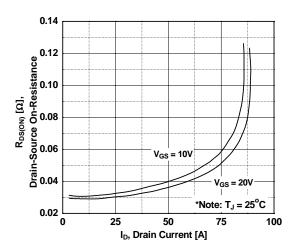


Figure 5. Capacitance Characteristics

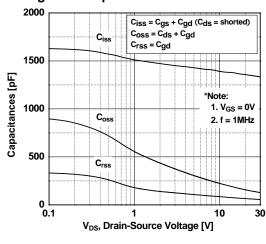


Figure 2. Transfer Characteristics

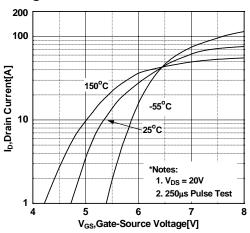


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

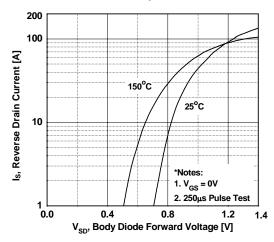
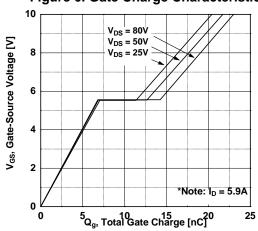


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

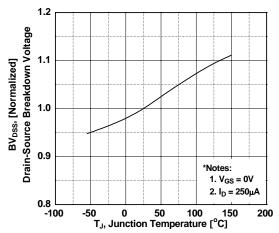


Figure 8. On-Resistance Variation vs. Temperature

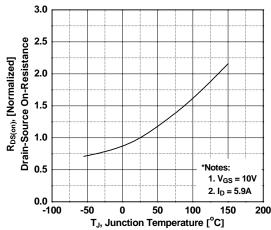
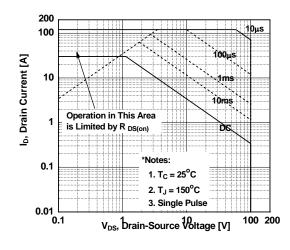


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature



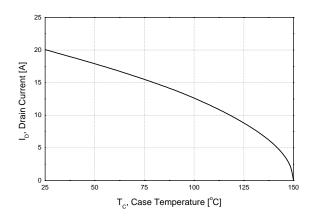
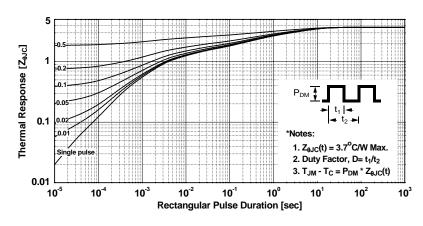
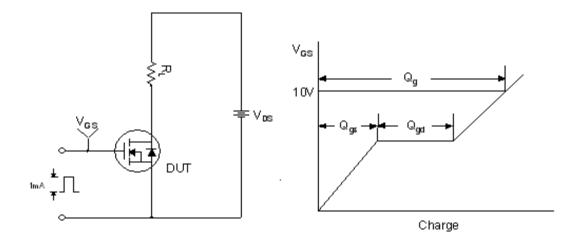


Figure 11. Transient Thermal Response Curve

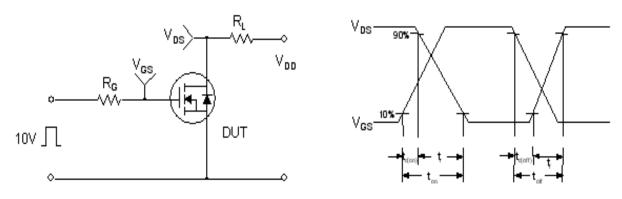


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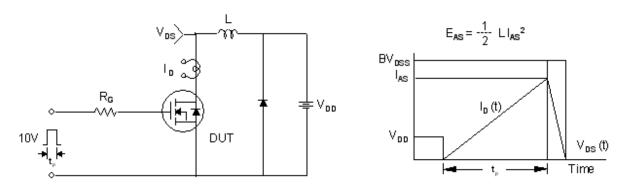
Gate Charge Test Circuit & Waveform



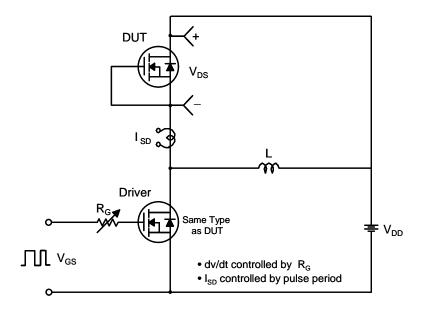
Resistive Switching Test Circuit & Waveforms

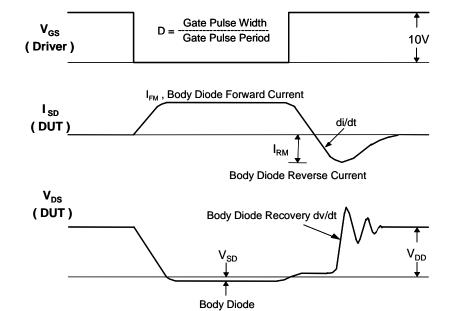


Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms





Forward Voltage Drop

Package Dimensions TO-220F 3.30 ± 0.10 2.54 ±0.20 10.16 ±0.20 $\emptyset 3.18 \pm 0.10$ (0.70)(7.00)6.68 ±0.20 15.87 ± 0.20 15.80 ±0.20 (1.00x45°) MAX1.47 9.75 ±0.30 0.80 ± 0.10 0.35 ± 0.10 $0.50^{\,+0.10}_{\,-0.05}$ 2.76 ± 0.20 2.54TYP 2.54TYP [2.54 ±0.20] [2.54 ±0.20] 4.70 ± 0.20 9.40 ± 0.20 Dimensions in Millimeters





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